



SEMITOP®E1

## Symmetrical Boost

Engineering Sample  
SK75GARL07S5TD1E1

## Target Data

## Features\*

- Optimized design for superior thermal performances
- Low inductive design
- Press-Fit contact technology
- 650V Trench5 IGBT (S5)
- Rapid switching diode technology
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

## Typical Applications

- UPS
- Solar

## Remarks

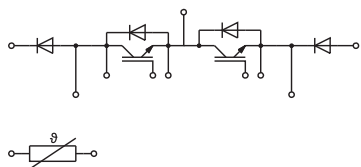
- Recommended  $T_{jop} = -40 \dots +150^\circ\text{C}$
- Diode1: outer Freewheeling Diodes
- Diode2: inner Antiparalell Diodes

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
IGBT 1				
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		650	V
I <sub>C</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	65	A
		T <sub>j</sub> = 175 °C	51	A
I <sub>C</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	79	A
		T <sub>j</sub> = 175 °C	63	A
I <sub>Cnom</sub>			75	A
I <sub>CRM</sub>			150	A
V <sub>GES</sub>			-20 ... 20	V
t <sub>psc</sub>	V <sub>CC</sub> = 360 V V <sub>GE</sub> ≤ 15 V V <sub>CES</sub> ≤ 650 V	T <sub>j</sub> = 150 °C	not capable	μs
T <sub>j</sub>			-40 ... 175	°C

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
Diode 1				
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		650	V
I <sub>F</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	63	A
		T <sub>j</sub> = 175 °C	49	A
I <sub>F</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	75	A
		T <sub>j</sub> = 175 °C	59	A
I <sub>FRM</sub>			150	A
I <sub>FSM</sub>	10 ms	T <sub>j</sub> = 25 °C	450	A
		T <sub>j</sub> = 150 °C	380	A
T <sub>j</sub>			-40 ... 175	°C

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
Diode 2				
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		650	V
I <sub>F</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	21	A
		T <sub>j</sub> = 175 °C	16	A
I <sub>F</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	23	A
		T <sub>j</sub> = 175 °C	18	A
I <sub>FRM</sub>			30	A
I <sub>FSM</sub>	10 ms	T <sub>j</sub> = 25 °C	-	A
	sin 180°	T <sub>j</sub> = 150 °C	-	A
T <sub>j</sub>			-40 ... 175	°C

Absolute Maximum Ratings			
Symbol	Conditions	Values	Unit
<b>Module</b>			
$I_{t(RMS)}$	$\Delta T_{terminal}$ at PCB joint = 30 K, per pin	30	A
$T_{stg}$		-40 ... 125	$^\circ\text{C}$
$V_{isol}$	AC, sinusoidal, $t = 1 \text{ min}$	2500	V



GARL-T



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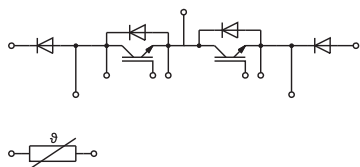
- UPS
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#### Remarks

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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT 1						
V <sub>CE(sat)</sub>	I <sub>C</sub> = 75 A	T <sub>j</sub> = 25 °C		1.42	1.75	V
	V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 150 °C		1.61	2.06	V
V <sub>CE0</sub>	chipelevel	T <sub>j</sub> = 25 °C		0.95	1.05	V
		T <sub>j</sub> = 150 °C		0.85	1.00	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 25 °C		6.3	9.3	mΩ
		T <sub>j</sub> = 150 °C		10	14	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 0.75 mA		3.2	4	4.8	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 650 V, T <sub>j</sub> = 25 °C				0.2	mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		4.5		nF
C <sub>oes</sub>		f = 1 MHz		0.13		nF
C <sub>res</sub>		f = 1 MHz		0.017		nF
Q <sub>G</sub>	V <sub>GE</sub> = -15V ... +15V			360		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			0		Ω
t <sub>d(on)</sub>	V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C		43		ns
t <sub>r</sub>	I <sub>C</sub> = 75 A	T <sub>j</sub> = 150 °C		34		ns
E <sub>on</sub>	V <sub>GE</sub> = +15/-15 V R <sub>G on</sub> = 15 Ω	T <sub>j</sub> = 150 °C		1.15		mJ
t <sub>d(off)</sub>	R <sub>G off</sub> = 15 Ω	T <sub>j</sub> = 150 °C		163		ns
t <sub>f</sub>	di/dt <sub>on</sub> = 1870 A/μs di/dt <sub>off</sub> = 1440 A/μs	T <sub>j</sub> = 150 °C		33		ns
E <sub>off</sub>	dv/dt = 7220 V/μs	T <sub>j</sub> = 150 °C		1.46		mJ
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =0.8 W/(mK)			1.18		K/W
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =2.5 W/(mK)			0.87		K/W

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Diode 1						
V <sub>F</sub>	I <sub>F</sub> = 75 A	T <sub>j</sub> = 25 °C		1.35	1.92	V
	chiplevel	T <sub>j</sub> = 150 °C		1.30	1.89	V
V <sub>F0</sub>		chiplevel	T <sub>j</sub> = 25 °C		0.90	1.10
			T <sub>j</sub> = 150 °C		0.71	0.94
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		6.0	11	mΩ
			T <sub>j</sub> = 150 °C		7.9	13
I <sub>RRM</sub>	I <sub>F</sub> = 75 A	T <sub>j</sub> = 150 °C		67		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 2270 A/μs	T <sub>j</sub> = 150 °C		4.36		μC
E <sub>rr</sub>	V <sub>GE</sub> = -15 V V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C		0.98		mJ
R <sub>th(j-s)</sub>	per Diode, λ <sub>paste</sub> =0.8 W/(mK)			1.39		K/W
R <sub>th(j-s)</sub>	per Diode, λ <sub>paste</sub> =2.5 W/(mK)			1.06		K/W



**GARL-T**

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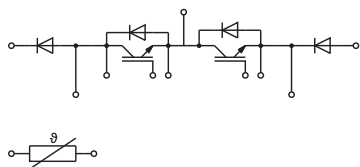
## Remarks

- Recommended  $T_{jop} = -40 \dots +150^\circ\text{C}$
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Diode 2						
V <sub>F</sub>	I <sub>F</sub> = 15 A	T <sub>j</sub> = 25 °C		1.55	1.87	V
	chiplevel	T <sub>j</sub> = 150 °C		1.45	1.74	V
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.10	1.32	V
		T <sub>j</sub> = 150 °C		0.95	1.14	V
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		30	37	mΩ
		T <sub>j</sub> = 150 °C		33	40	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 15 A			-		A
Q <sub>rr</sub>				-		μC
E <sub>rr</sub>				-		mJ
R <sub>th(j-s)</sub>	per Diode, λ <sub>paste</sub> =0.8 W/(mK)			3.62		K/W
R <sub>th(j-s)</sub>	per Diode, λ <sub>paste</sub> =2.5 W/(mK)			3.27		K/W

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
Module					
M <sub>s</sub>	to heatsink	1.6		2.3	Nm
w	weight		25		g

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
Temperature Sensor					
R <sub>25</sub>	T <sub>r</sub> =25°C		22 ±5%		kΩ
B <sub>25/50</sub>	R(T)=R <sub>25</sub> exp[B <sub>25/50</sub> (1/T-1/T <sub>25</sub> )]; T[K]		3950 ±3%		K



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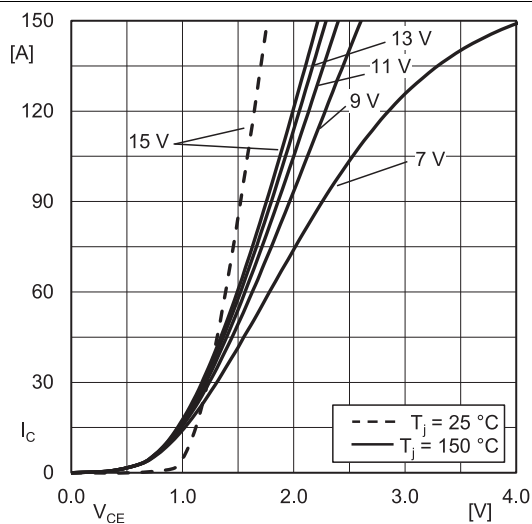


Fig. 1: Typ. IGBT output characteristic, incl.  $R_{CC+EE'}$

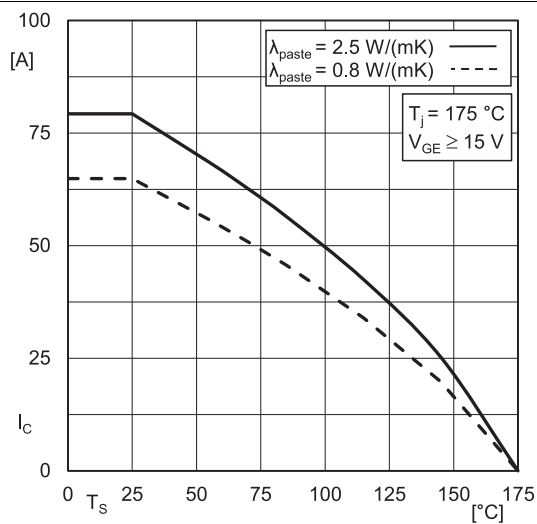


Fig. 2: IGBT rated current vs. temperature  $I_C=f(T_s)$

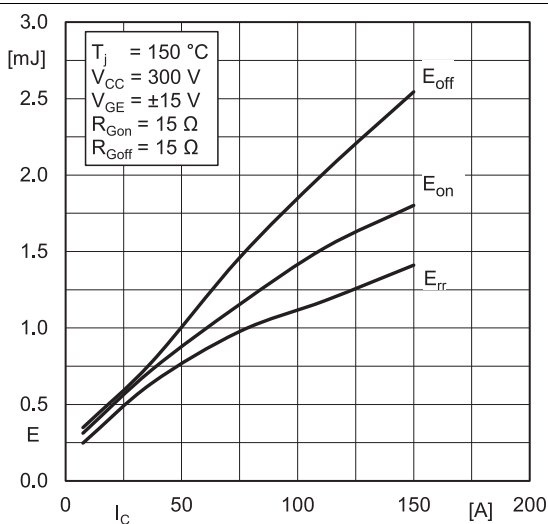


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

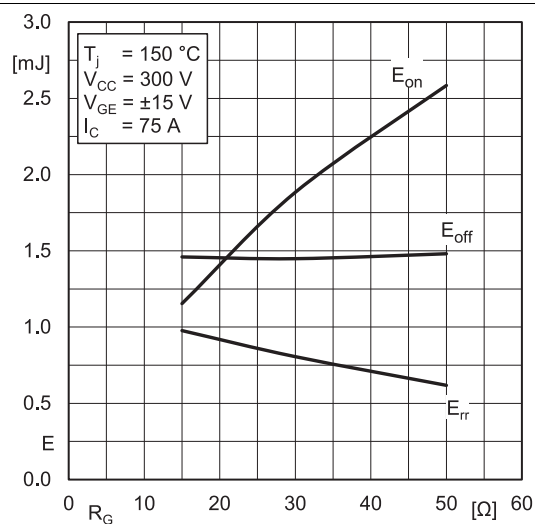


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

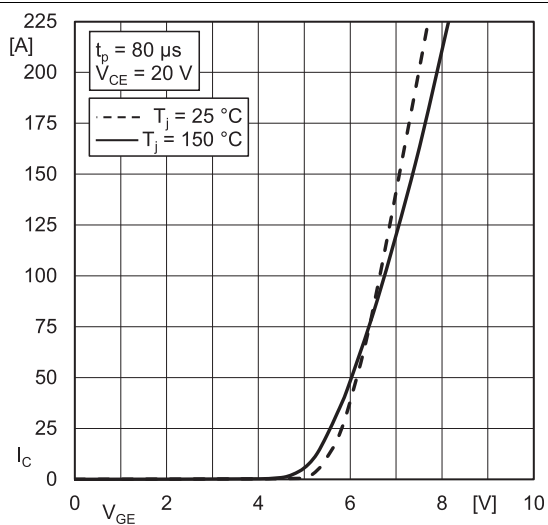


Fig. 5: Typ. IGBT transfer characteristic

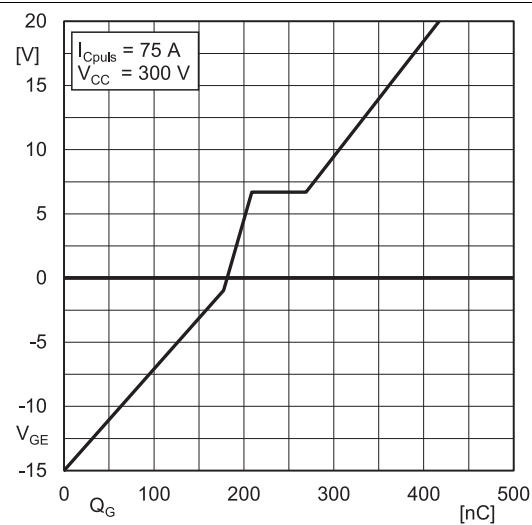


Fig. 6: Typ. IGBT gate charge characteristic

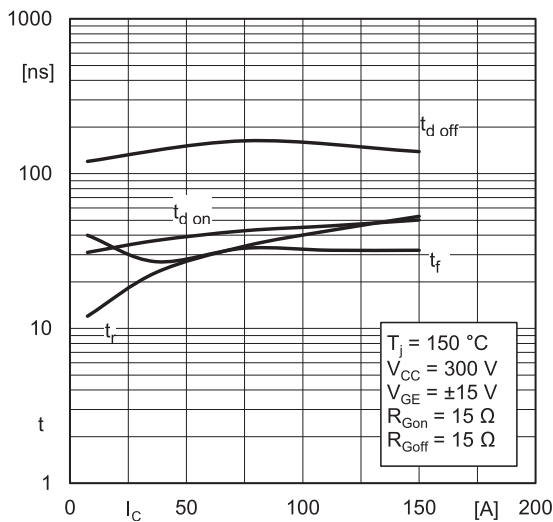


Fig. 7: Typ. switching times =  $f(I_C)$

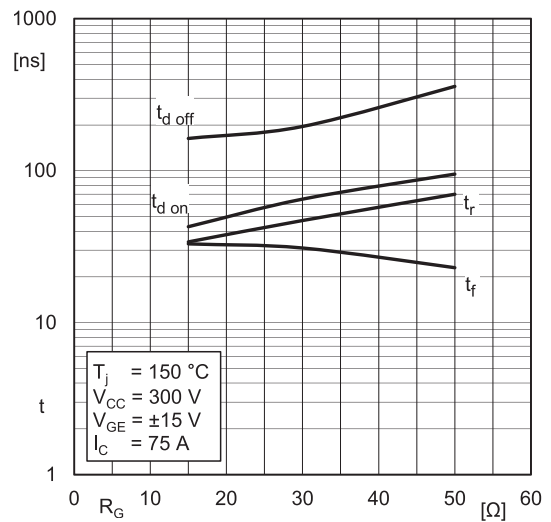


Fig. 8: Typ. switching times =  $f(R_G)$

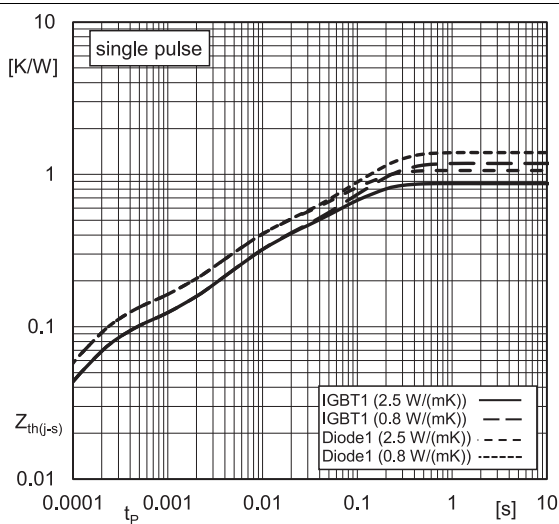


Fig. 9: Typ. transient thermal impedance

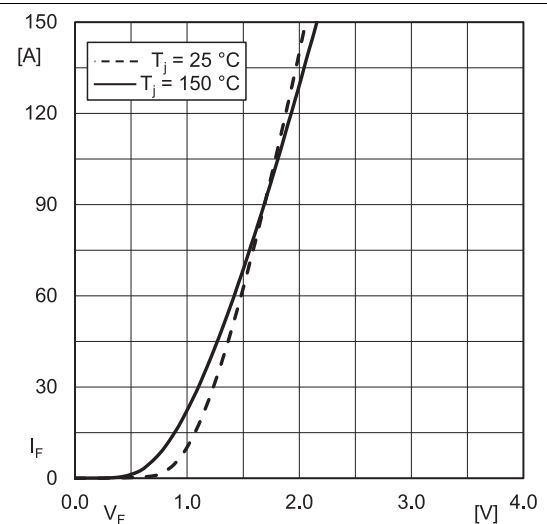


Fig. 10: Typ. Diode1 forward characteristic, incl.  $R_{CC}+EE'$

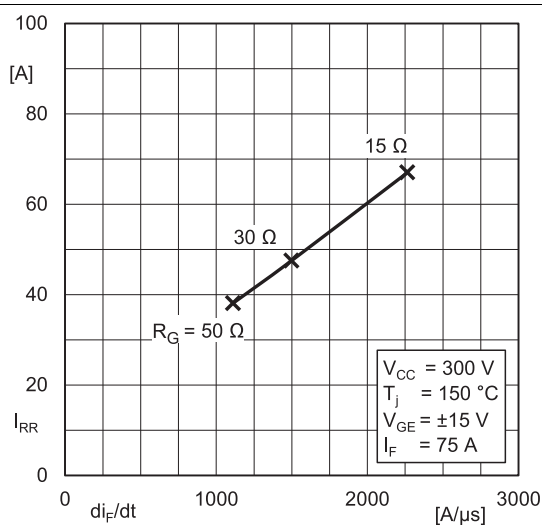


Fig. 11: Typ. Diode peak reverse recovery current

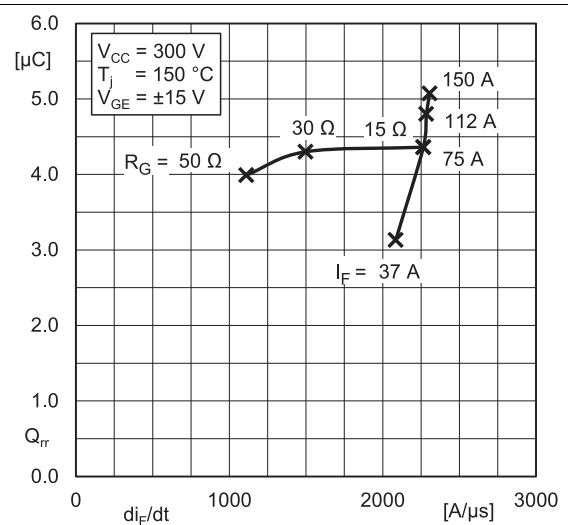
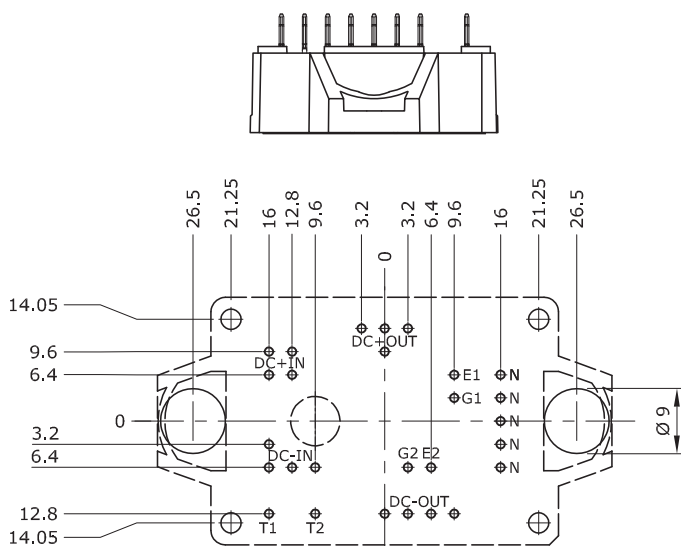
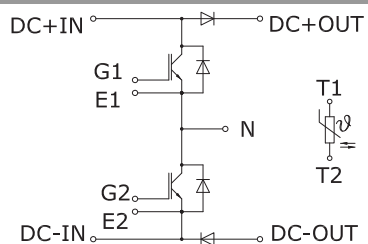


Fig. 12: Typ. Diode reverse recovery charge



- Pin-Grid 3.2 mm
- Tolerance of PCB hole pattern  $\begin{array}{|c|c|} \hline \oplus & \varnothing 0.1 \\ \hline \end{array}$
- Diameters of drill  $\varnothing$  1.15mm
- Copper thickness in hole 25 - 50  $\mu$ m
- Hole specification for contacts:  
refer to SEMITOP E1/E2 Mounting Instruction

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This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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